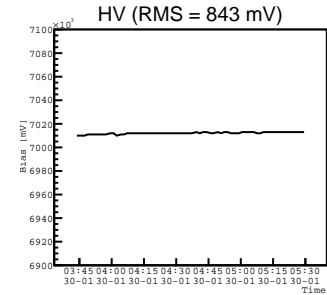
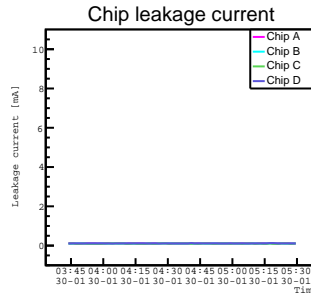
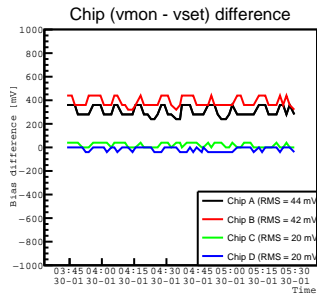
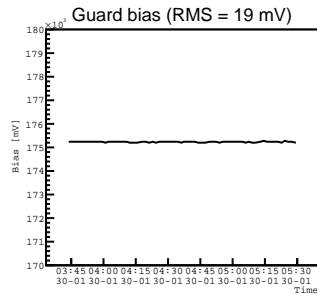


End of measuring: Sat Jan 30 07:02:08 2016

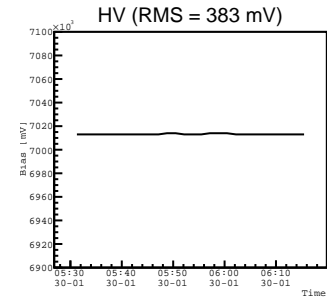
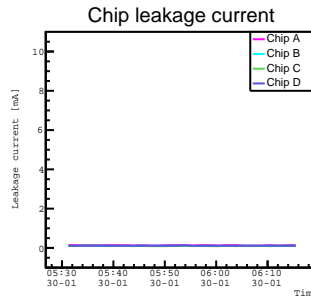
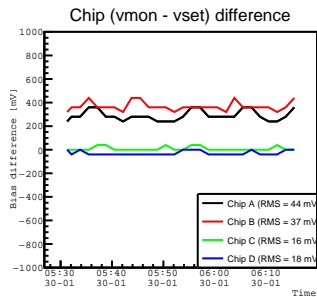
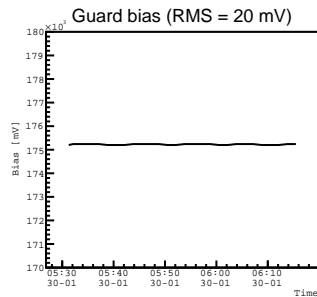
Threshold and Waveform

Sat Jan 30 03:43:51 2016



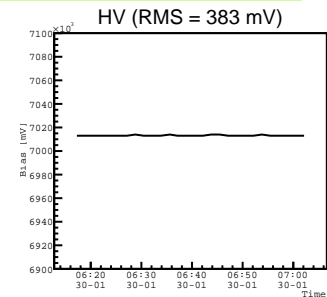
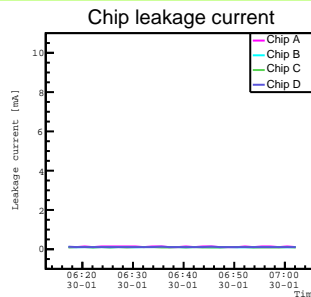
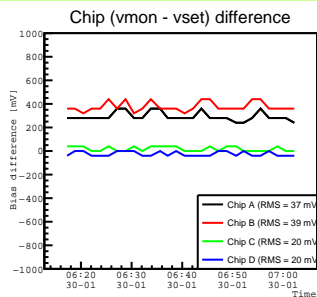
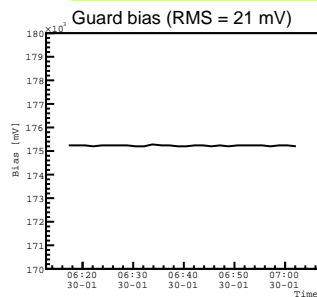
2D in X

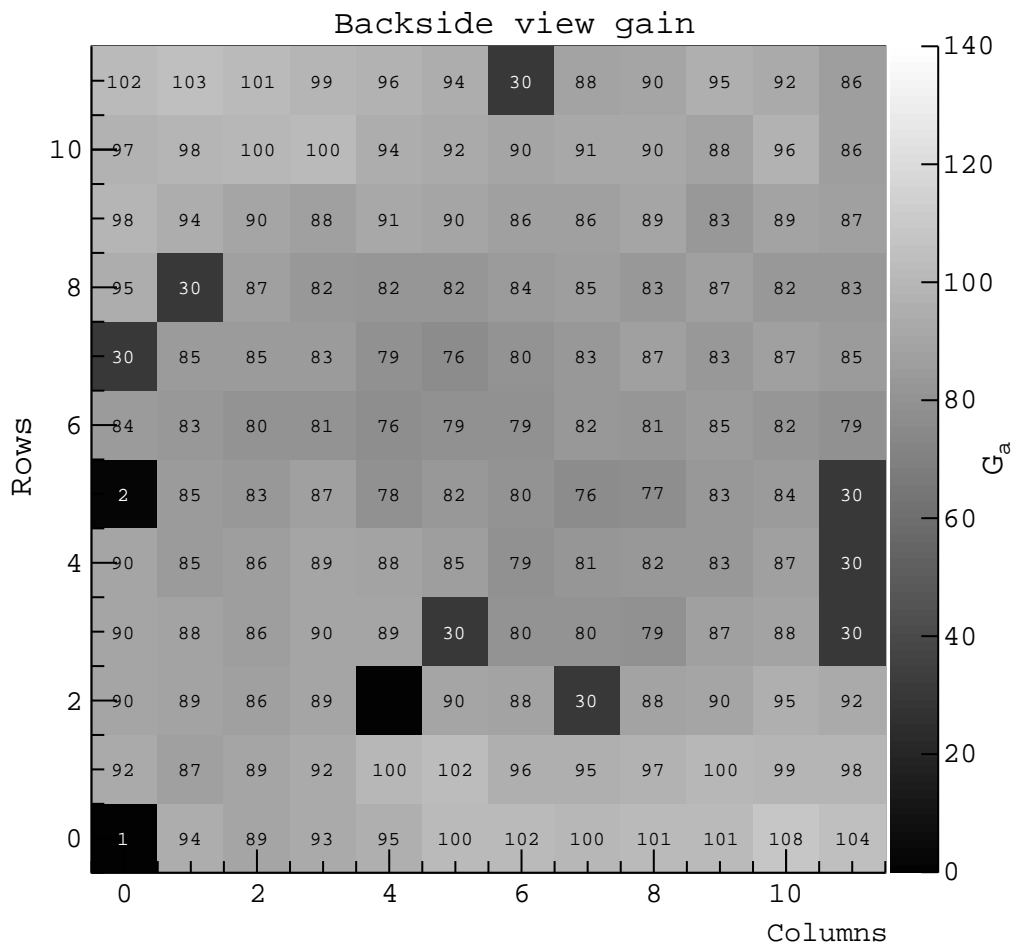
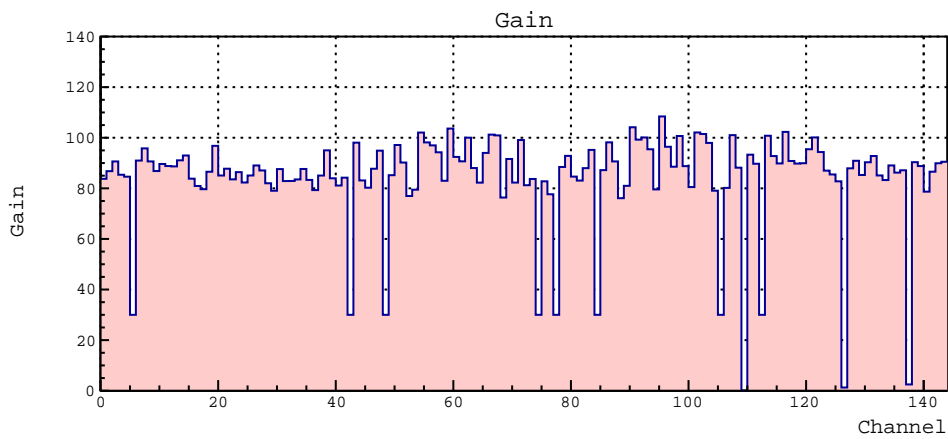
Sat Jan 30 05:31:16 2016



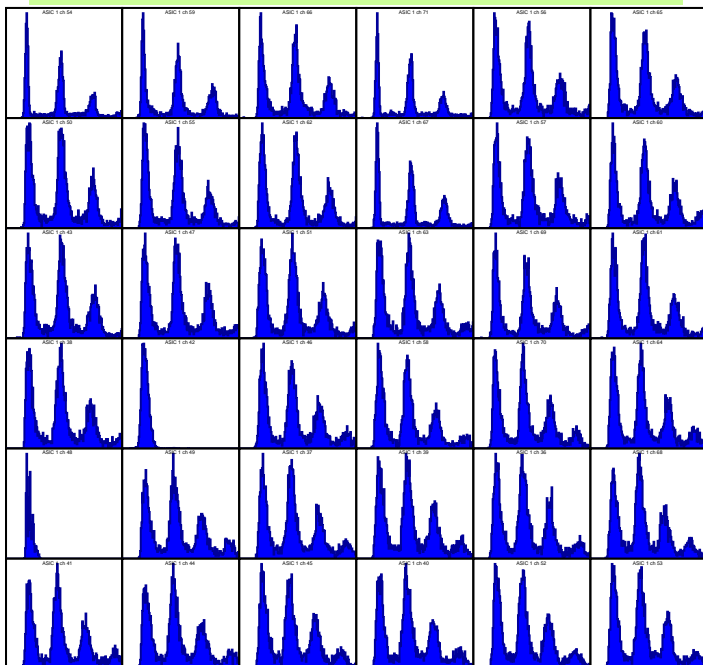
2D in Y

Sat Jan 30 06:17:16 2016

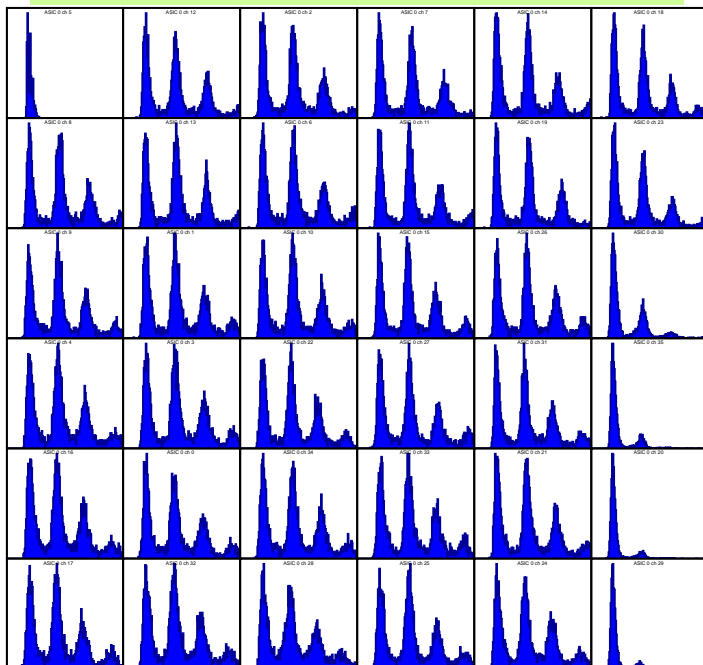




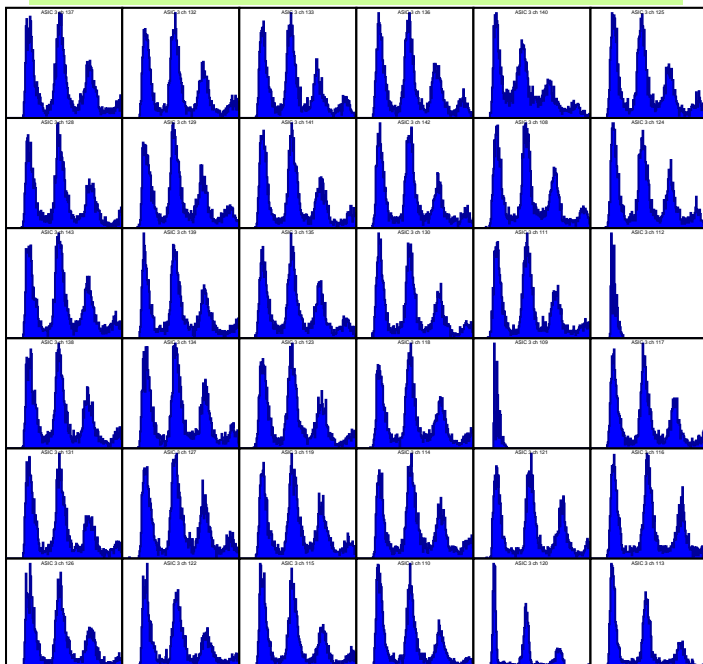
Charge scan over center of channels: Chip B



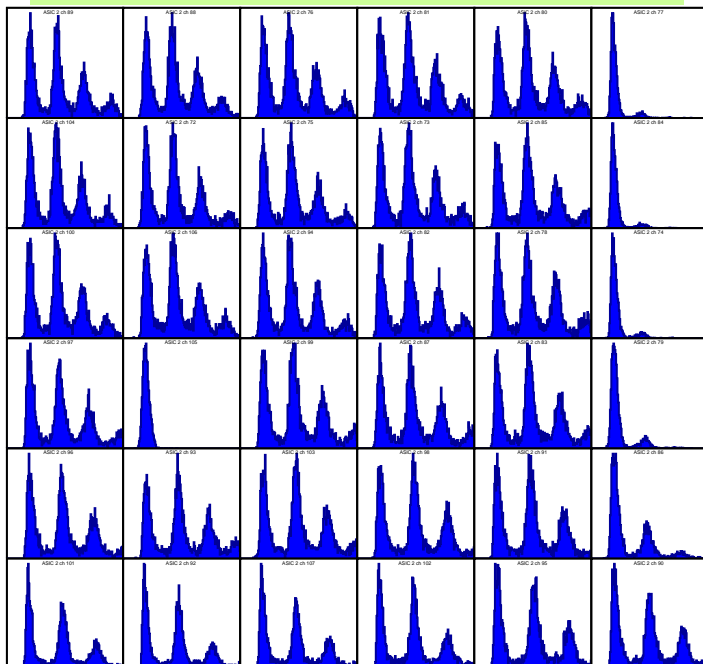
Charge scan over center of channels: Chip A



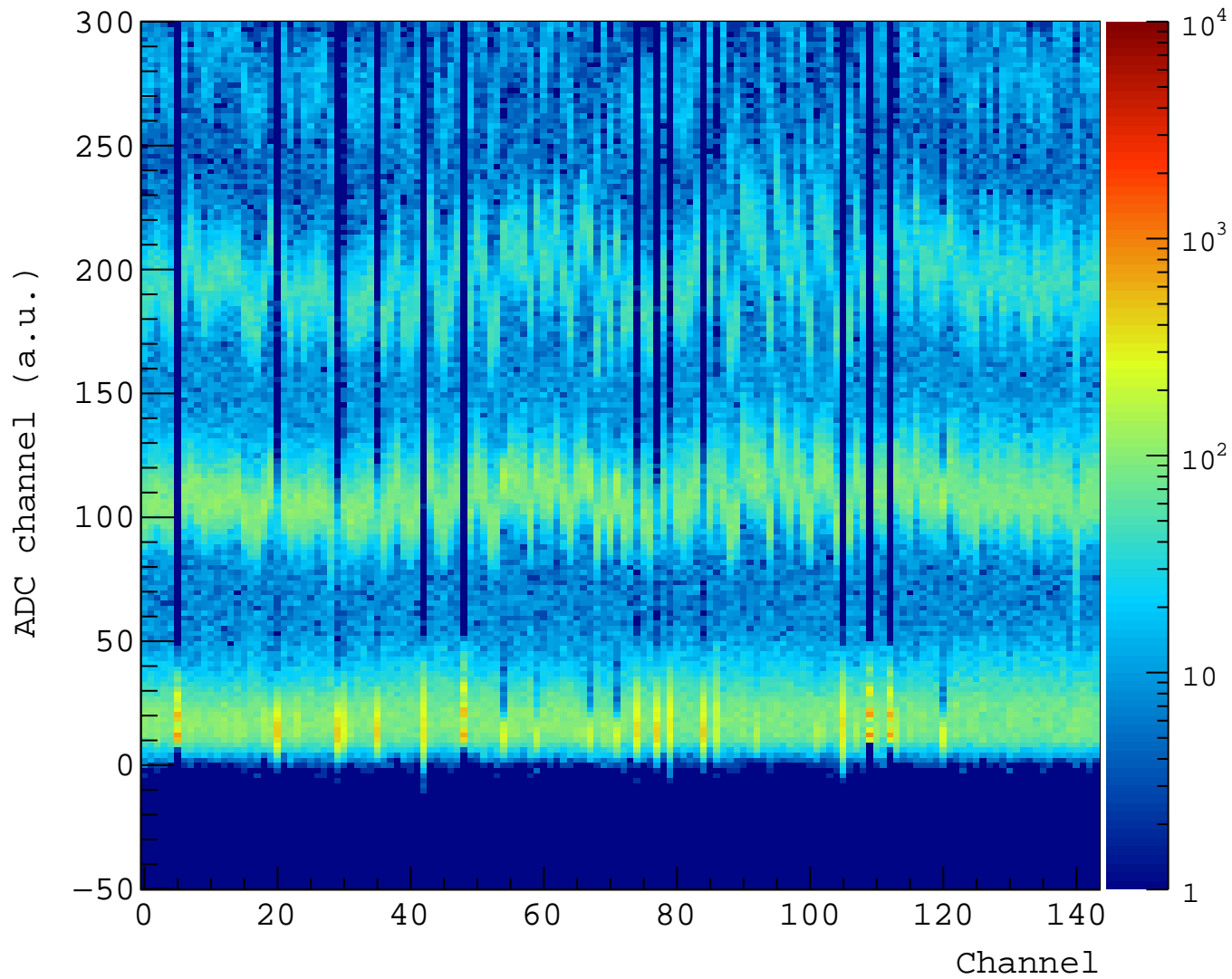
Charge scan over center of channels: Chip C



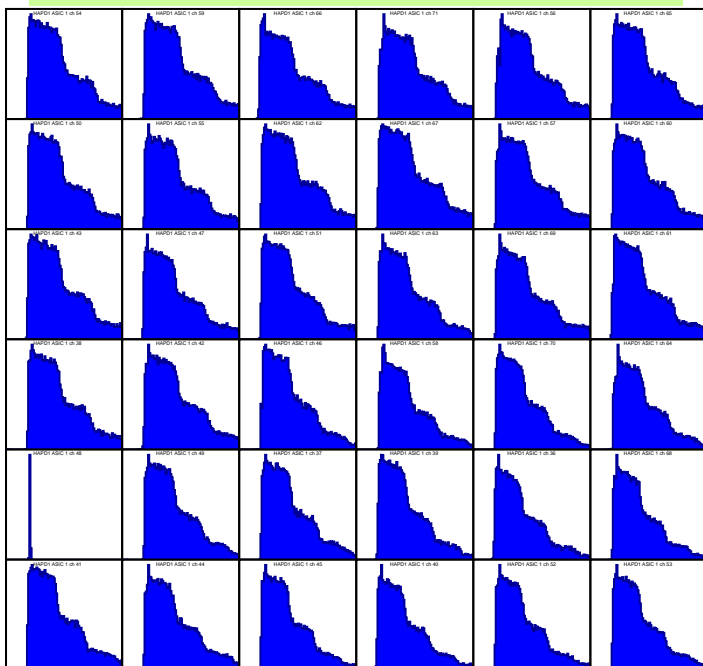
Charge scan over center of channels: Chip D



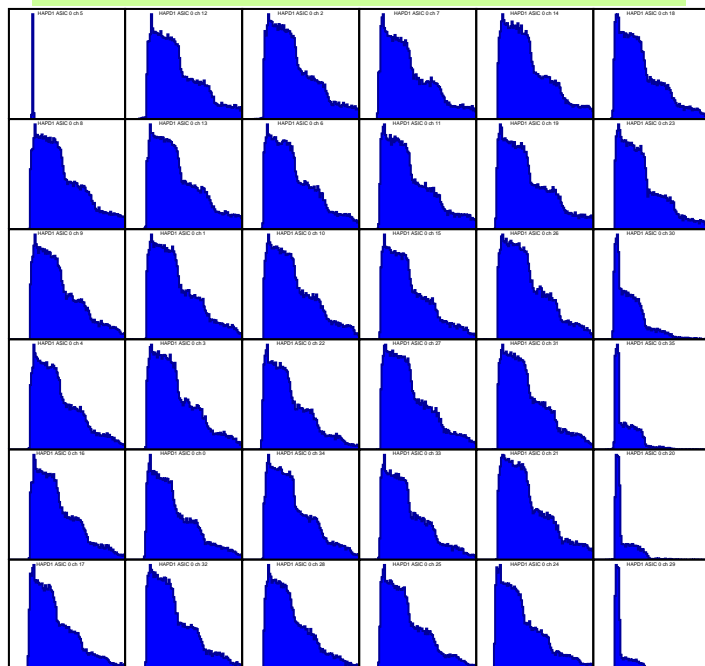
Charge scan over the center of channels



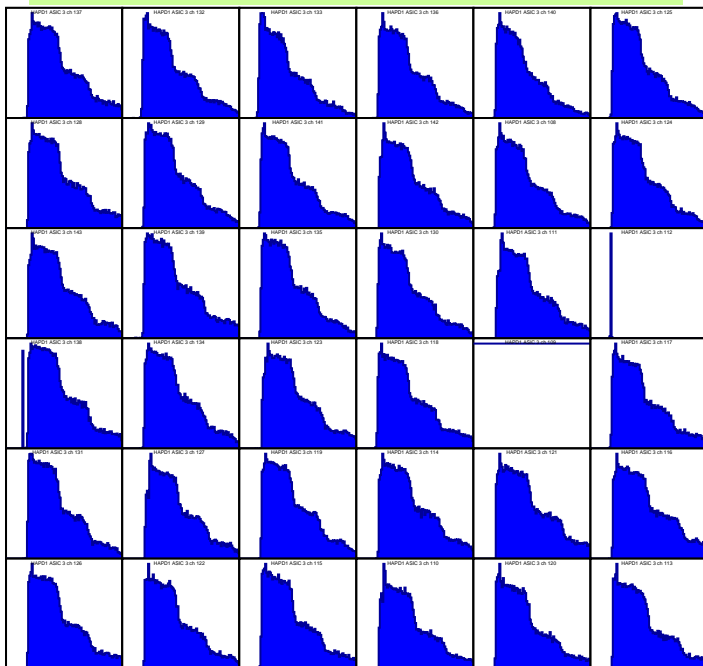
Threshold scan over center of channels: Chip B



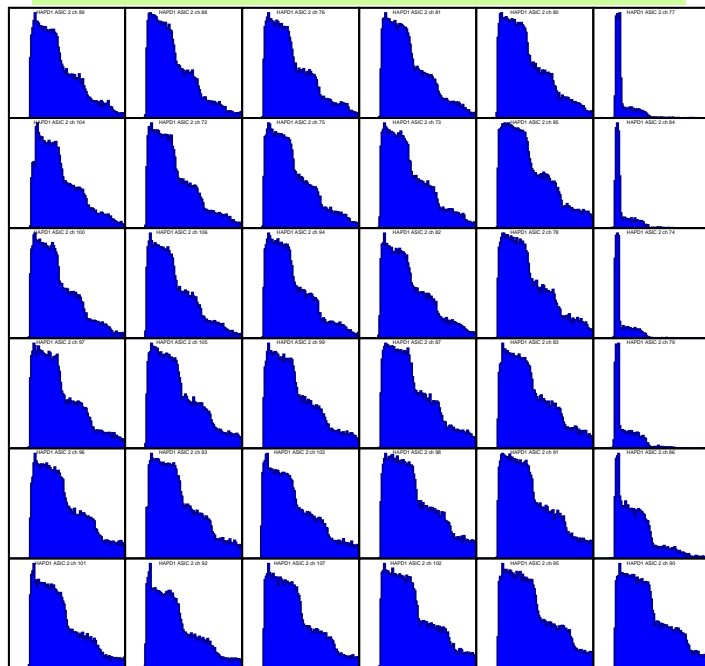
Threshold scan over center of channels: Chip A



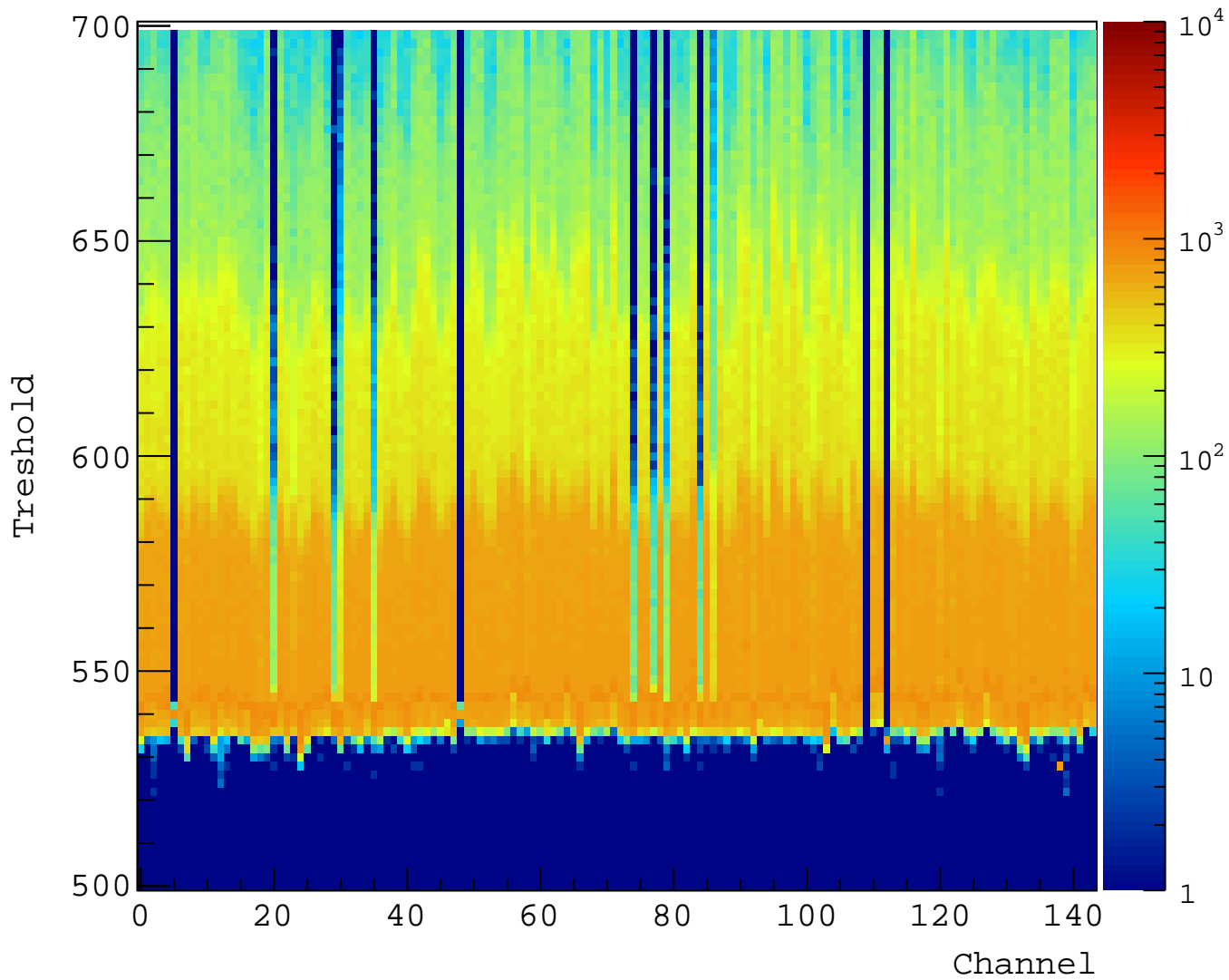
Threshold scan over center of channels: Chip C



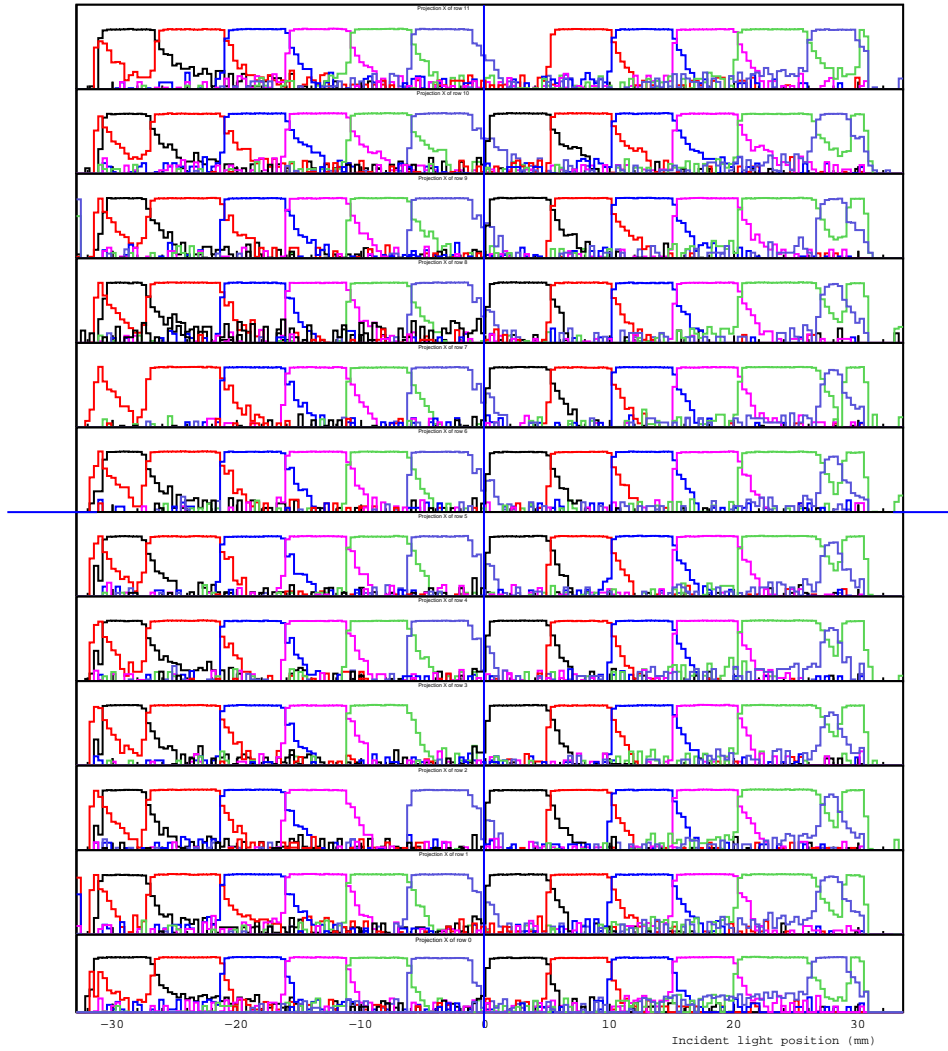
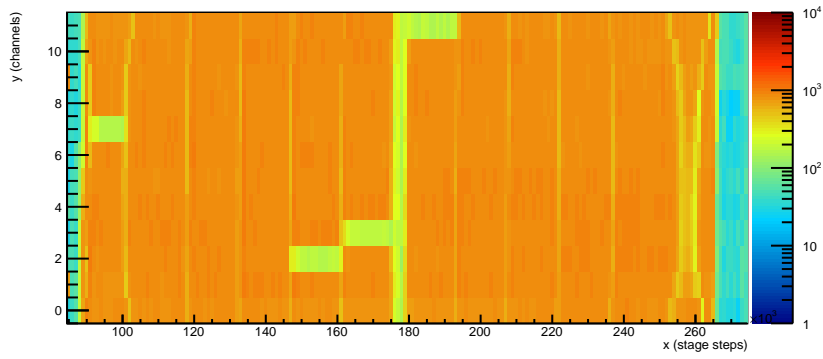
Threshold scan over center of channels: Chip D

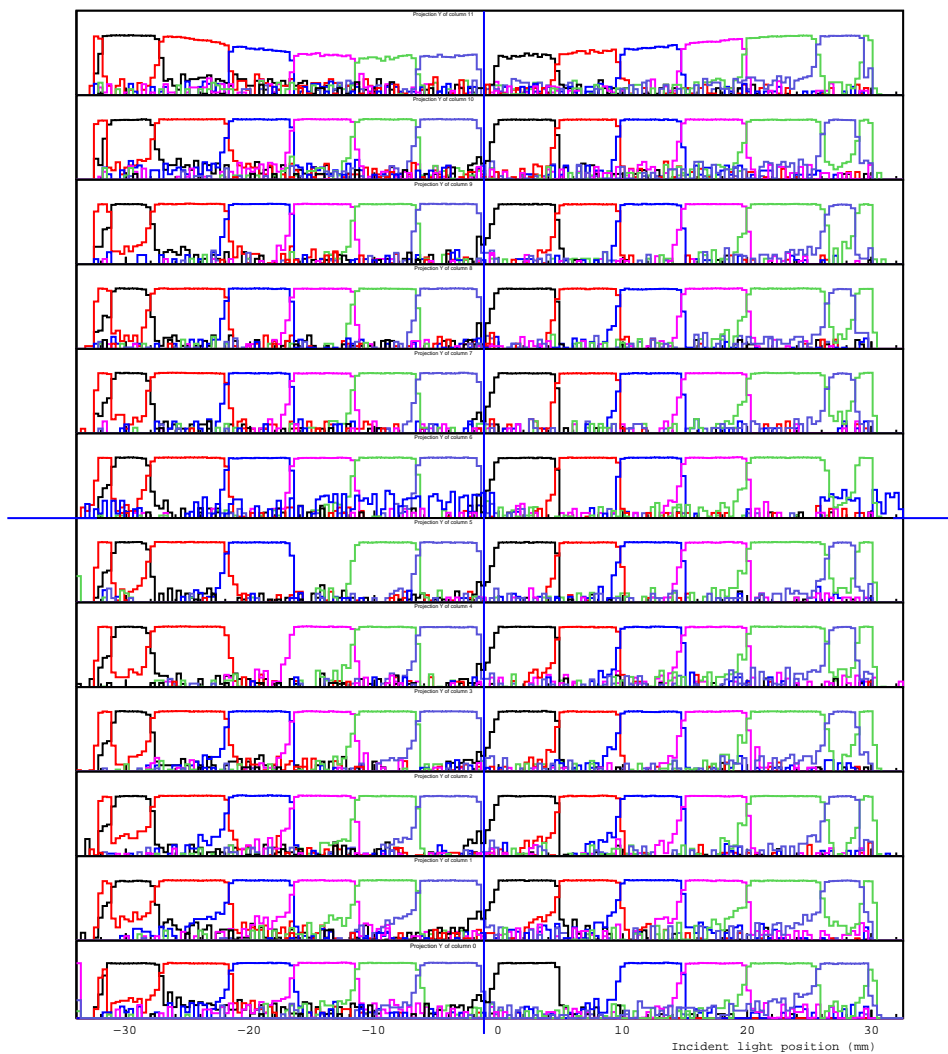
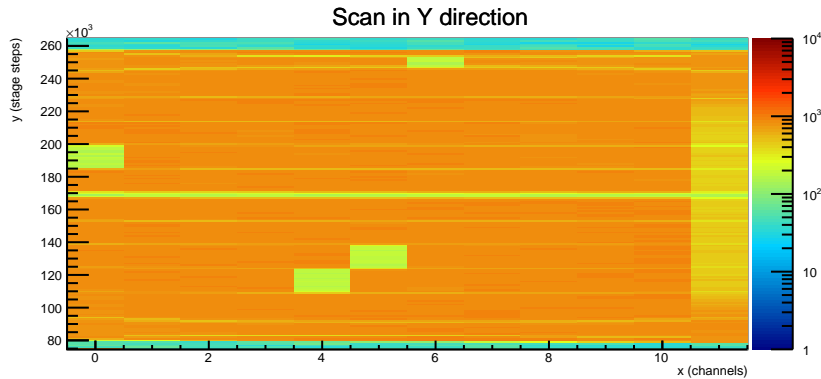


Threshold scan over the center of channels

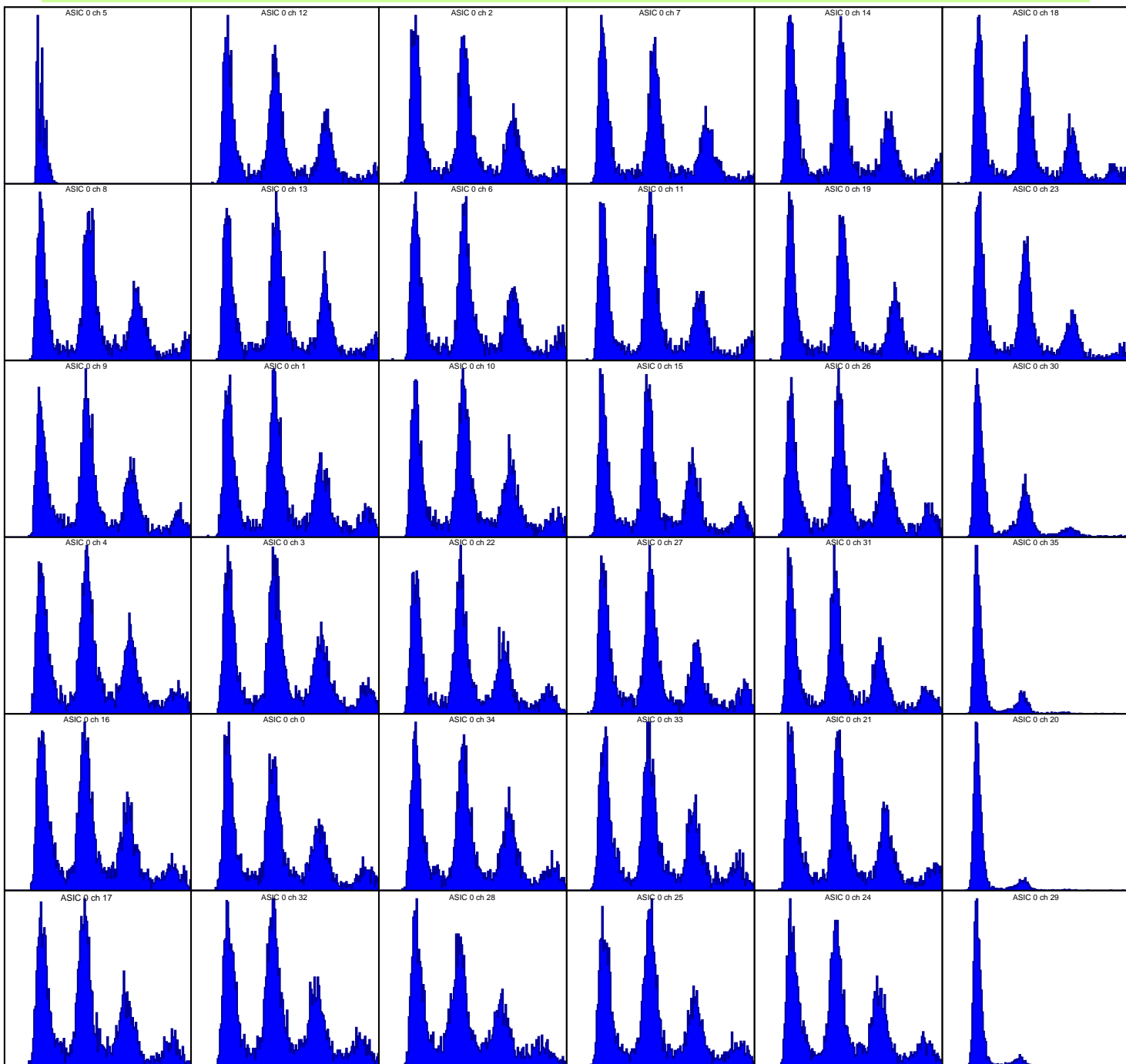


Scan in X direction

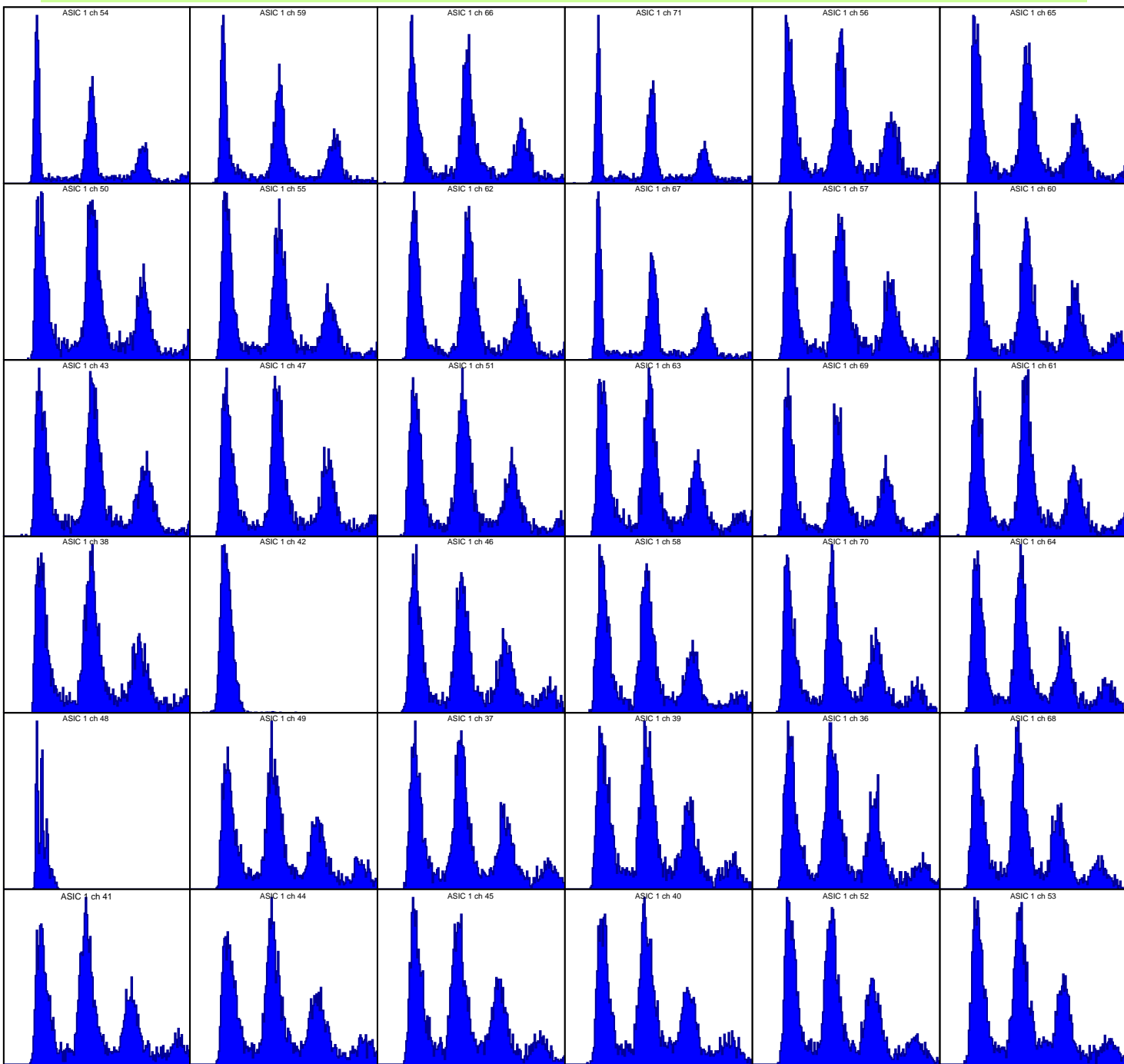




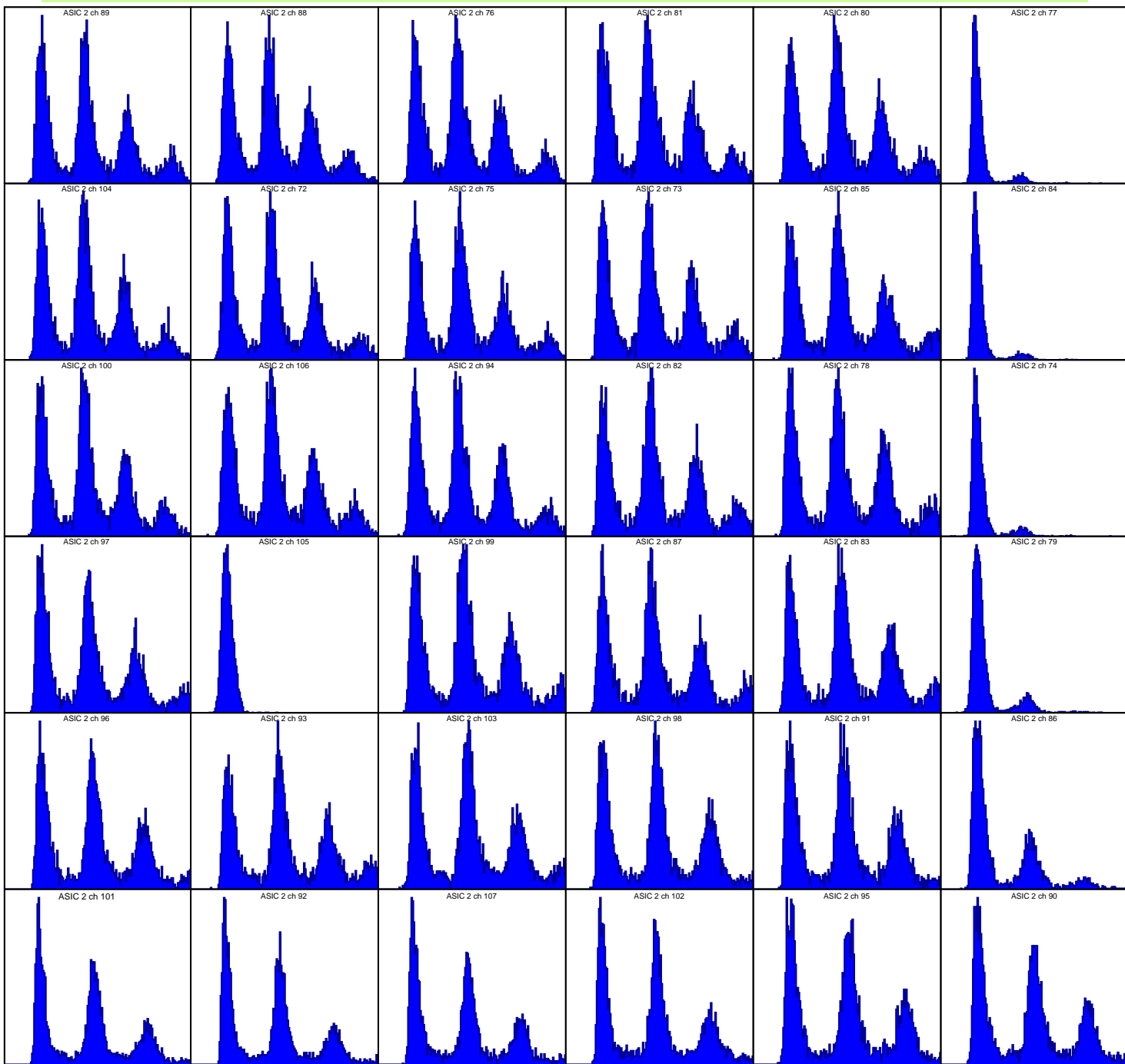
Charge scan over center of channels: Chip A



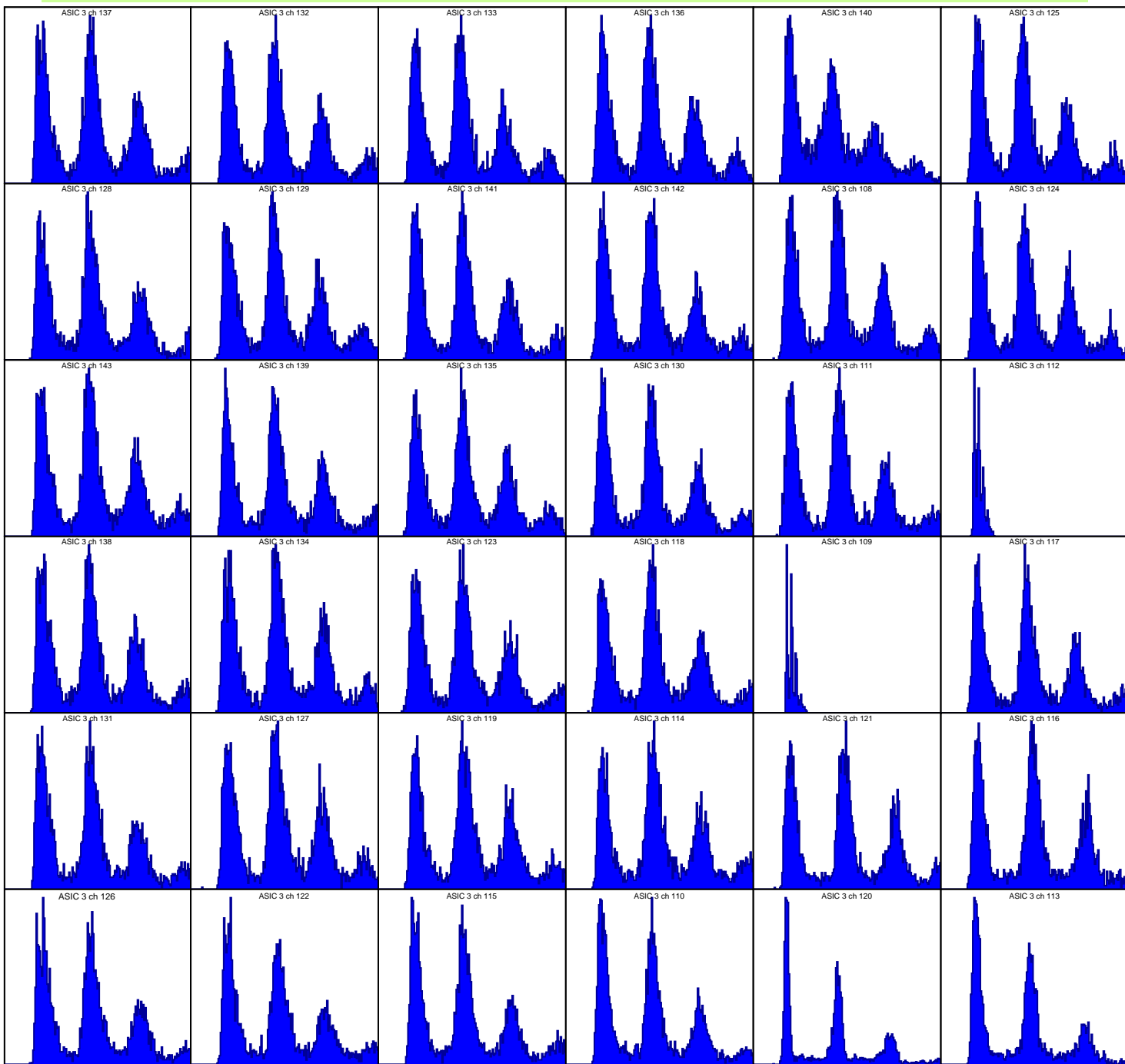
Charge scan over center of channels: Chip B



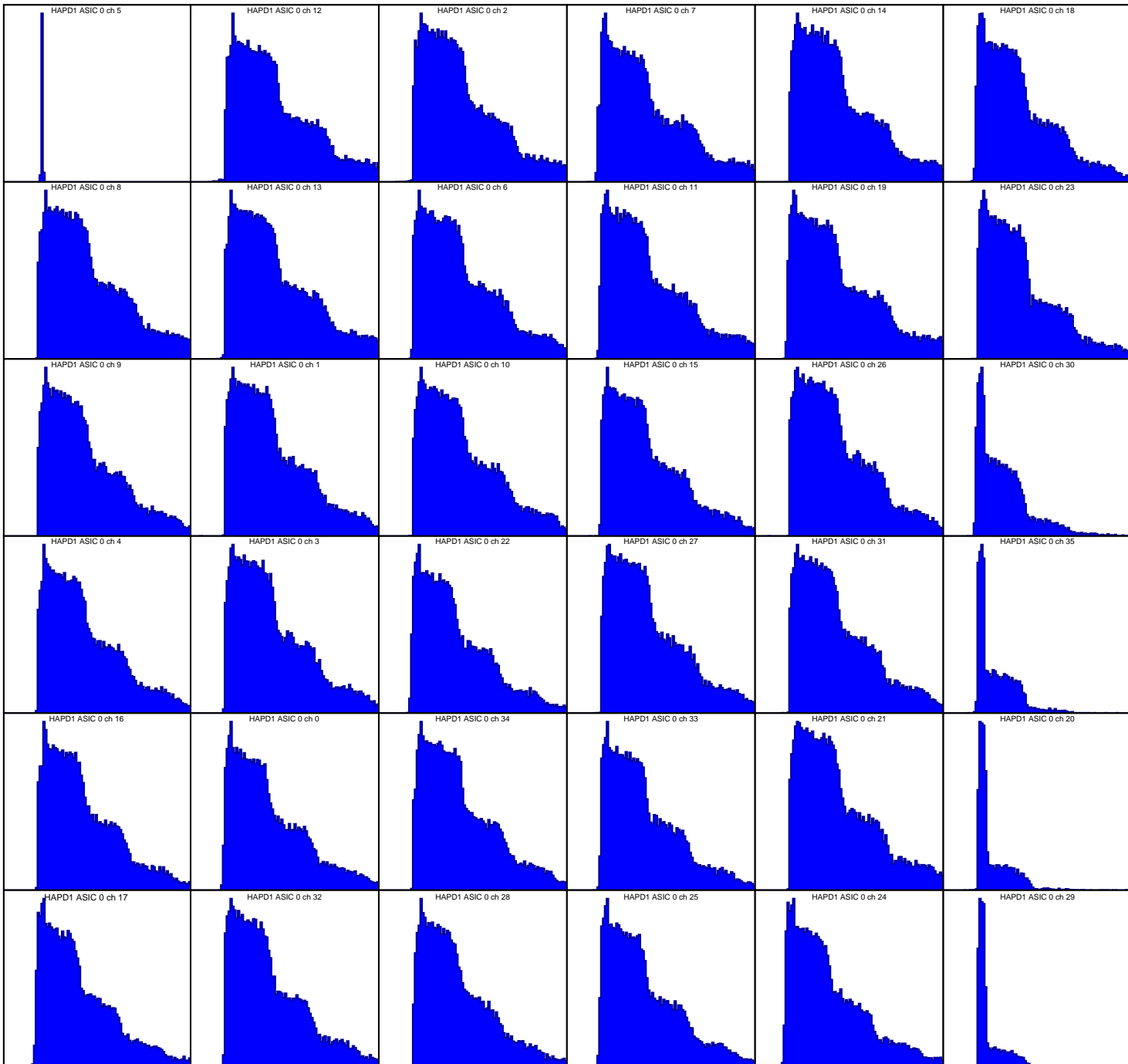
Charge scan over center of channels: Chip D



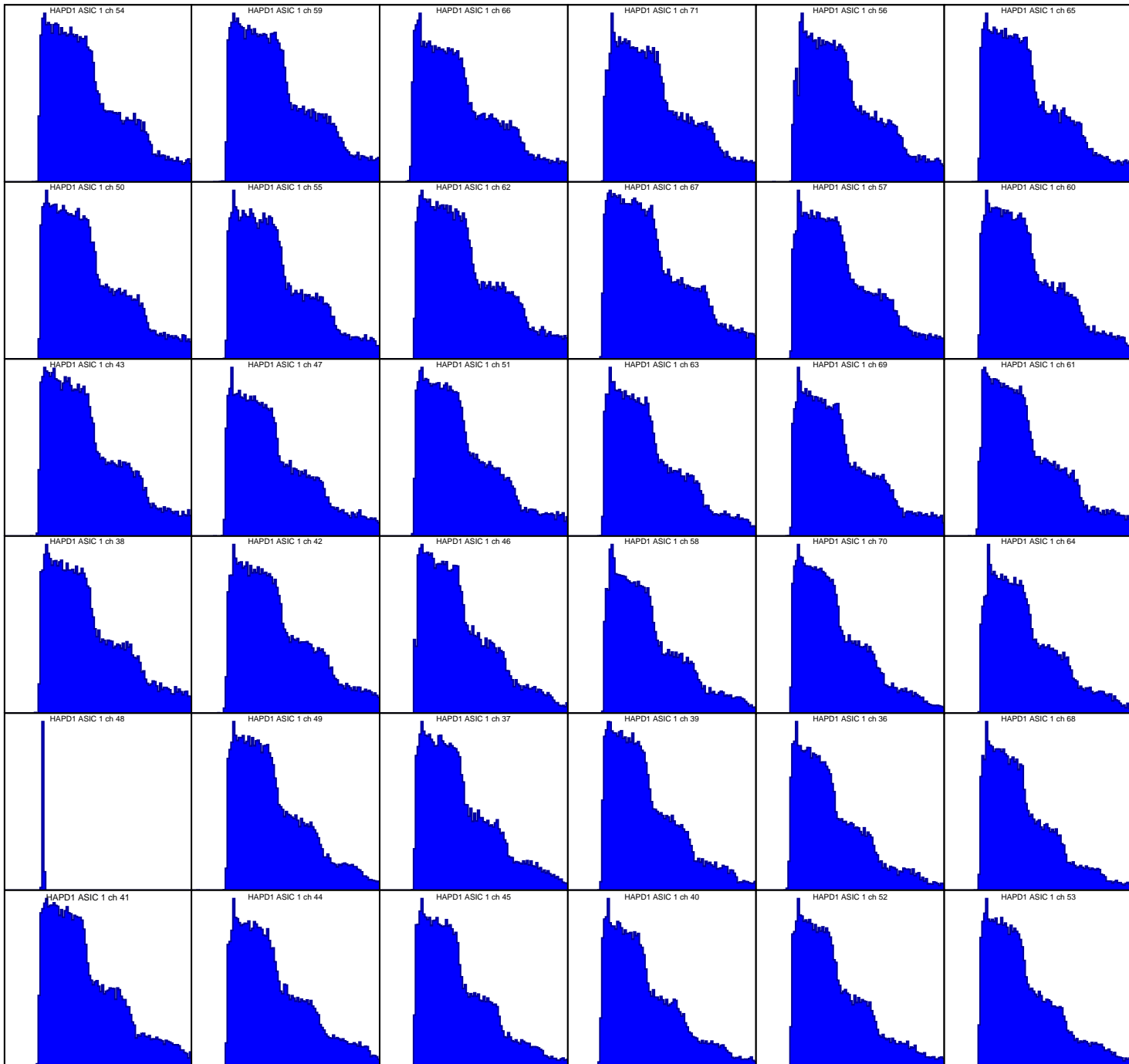
Charge scan over center of channels: Chip C



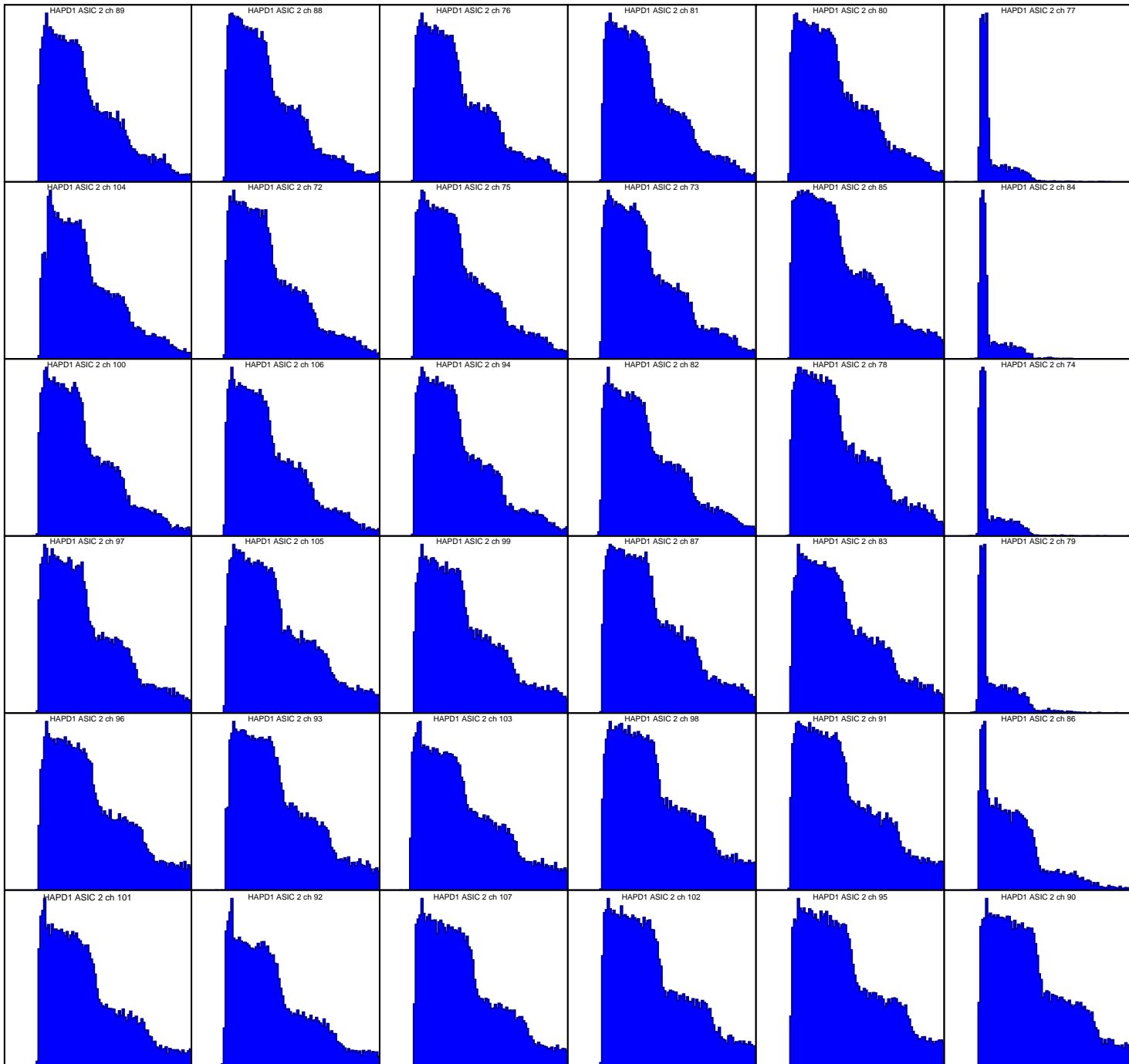
Threshold scan over center of channels: Chip A



Threshold scan over center of channels: Chip B



Threshold scan over center of channels: Chip D



Threshold scan over center of channels: Chip C

